

SEMITOP[®] 3

IGBT Module

SK15GD065ET

Preliminary Data

Features

- Compact design
- · One screw mounting
- · Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- Ultrafast NPT technology IGBT
- CAL technology FWD
- Integrated NTC temperature sensor

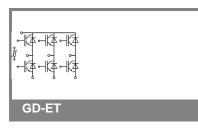
Typical Applications*

Inverter

 $T_s = 25 \text{ °C}$, unless otherwise specified **Absolute Maximum Ratings** Symbol Conditions Values Units IGBT V_{CES} T_i = 25 °C 600 V T_i = 125 °C T_e = 25 °C 20 А Ι_C T_s = 80 °C 14 А 30 А I_{CRM}= 2 x I_{Cnom} I_{CRM} ± 20 V V_{GES} V_{CC} = 300 V; $V_{GE} \le 20$ V; T_i = 125 °C 10 μs t_{psc} VCES < 600 V Inverse Diode T_i = 150 °C T_s = 25 °C 22 А I_F T_s = 80 °C 15 А I_{FRM}= 2 x I_{Fnom} 30 А I_{FRM} Module А I_{t(RMS)} T_{vj} -40 ... +150 °C T_{stg} -40 ... +125 °C 2500 V V_{isol} AC, 1 min. T_s = 25 °C, unless otherwise specified **Characteristics** Symbol Conditions min. max. Units typ. IGBT V_{GE(th)} $V_{GE} = V_{CE}, I_C = 0.4 \text{ mA}$ $V_{GE} = 0 \text{ V}, V_{CE} = V_{CES}$ 3 4 5 V 0,07 T_i = 25 °C mΑ ICES T_i = 125 °C mΑ V_{CE} = 0 V, V_{GE} = 20 V T_i = 25 °C 120 nA I_{GES} T_i = 125 °C nA T_i = 25 °C V V_{CE0} 1,2 1,3 V T_i = 125 °C 1,1 0,9 T_i = 25°C V_{GE} = 15 V 80 120 mΩ r_{CE} T_i = 125°C 110 mΩ I_{Cnom} = 15 A, V_{GE} = 15 V 2 2,5 ٧ V_{CE(sat)} T_j = 25°C_{chiplev}. T_i = 125°C_{chipley} 2,2 V Cies 0.8 nF V_{CE} = 25, V_{GE} = 0 V f = 1 MHz 0,084 Coes nF 0,052 C_{res} nF 45 ns t_{d(on)} V_{CC} = 300V R_{Gon} = 125 Ω 40 ns E_{on} I_C= 10A 0,3 mJ

T_i = 125 °C

V_{GE}=±15V



 R_{Goff} = 125 Ω

per IGBT

t_{d(off)}

R_{th(j-s)}

t, $\mathsf{E}_{\mathsf{off}}$ ns

ns

mJ

K/W

1,9

340

90

0,22



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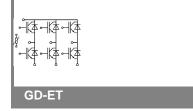
Typical Applications*

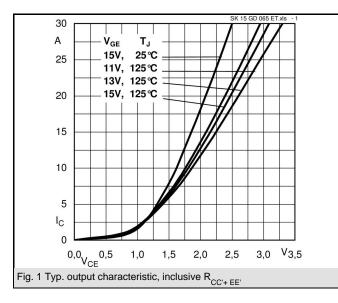
Inverter

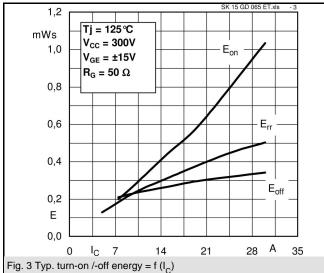
	Conditions		min.	typ.	max.	Units
Inverse D				.,6.	maxi	
$V_F = V_{EC}$	I _{Fnom} = 10 A; V _{GE} = 0 V	T _i = 25 °C _{chiplev.}		1,4	1,7	V
		T _j = 125 °C _{chiplev.}		1,4		V
V _{F0}		T _j = 25 °C		1	1,1	V
		T _j = 125 °C		0,9		V
r _F		T _j = 25 °C		45	60	mΩ
		T _j = 125 °C		50		mΩ
I _{RRM}	I _F = 10 A	T _j = 125 °C		11		А
Q _{rr}	di/dt = -290 A/µs	-		1,1		μC
Err	V _{CC} = 300V			0,24		mJ
R _{th(j-s)D}	per diode				2,3	K/W
M _s	to heat sink		2,25		2,5	Nm
w				30		g
Temperat	ture sensor					
R ₁₀₀	T _s =100°C (R ₂₅ =5kΩ)			493±5%		Ω

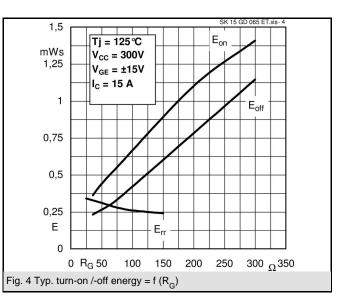
This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

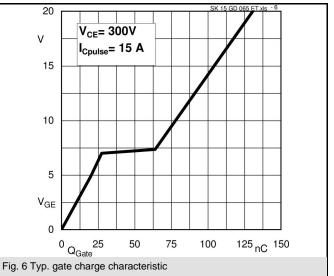
* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.

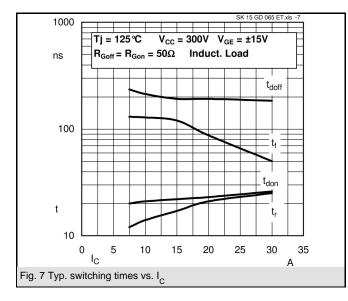


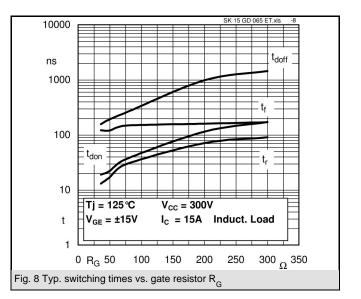


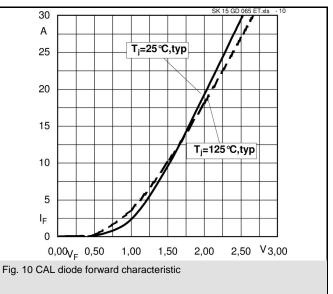




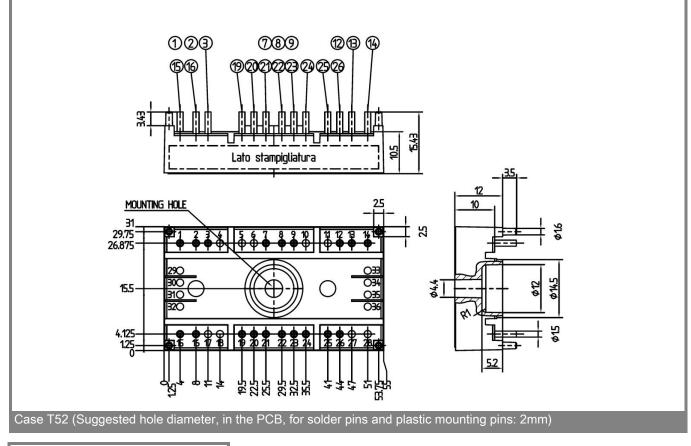


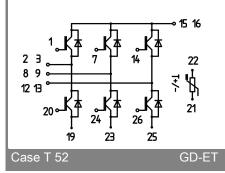






UL recognized file





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